Document Number: MC33897

Rev. 16.0, 6/2007

# Single Wire CAN Transceiver

The 33897 Series provides a physical layer for digital communications purposes using a Carrier Sense Multiple Access/Collision Resolution (CSMA/CR) data link operating over a single wire medium. This is more commonly referred to as Single Wire Controller Area Network (CAN).

The 33897 Series operates directly from a vehicle's 12 V battery system or a broad range of DC-power sources. It can operate at either low or high (33.33 kbps or 83.33 kbps) data rates. A high-voltage wake-up feature allows the device to control the regulator used in support of the MCU and other logic. The device includes a control terminal that can be used to put the module regulator into Sleep mode. The presence of a defined wake-up voltage level on the bus will reactivate the control line to turn the regulator and the system back on.

The device complies with the GMW3089v2.4 General Motors Corporation specification.

# 33897/A/B/C/D/T

#### SINGLE WIRE CAN TRANSCEIVER





D SUFFIX
EF (PB-FREE) SUFFIX
98ASB42565B
14-TERMINAL SOICN

EF (PB-FREE) SUFFIX 98ASB42564B 8-TERMINAL SOICN

#### **Features**

- · Waveshaping for Low Electromagnetic Interference (EMI)
- · Detects and Automatically Handles Loss of Ground
- Worst-Case Sleep Mode Current of Only 60 μA (75 μA on the 33897T)
- · Current Limit Prevents Damage Due to Bus Shorts
- · Built-In Thermal Shutdown on Bus Output
- · Protected Against Vehicular Electrical Transients
- · Undervoltage Lockout Prevents False Data with Low Battery
- · Pb-Free Packaging Designated by Suffix Code EF

ORDERING INFORMATION								
Contains Lead	Pb-Free	RoHS	Temperature Range (T <sub>A</sub> )	Package				
MC33897D/R2 MC33897AD/R2	MC33897EF/R2 MC33897AEF/R2	MCZ33897EF/R2 MCZ33897TEF/R2 MCZ33897AEF/R2 *MCZ33897CEF/R2	-40°C to 125°C	14 SOICN				
	MC33897BEF/R2	MCZ33897BEF/R2 *MCZ33897DEF/R2		8 SOICN				

<sup>\*</sup>Recommended device for all new designs



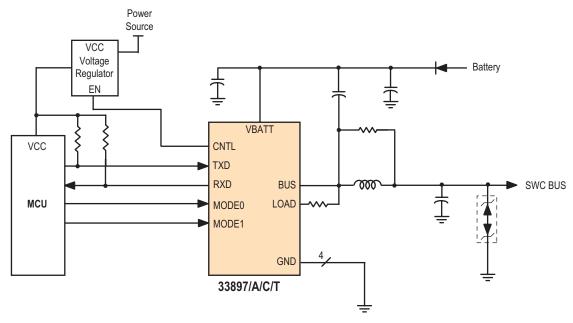


Figure 1. 33897/A/C Simplified Application Diagram

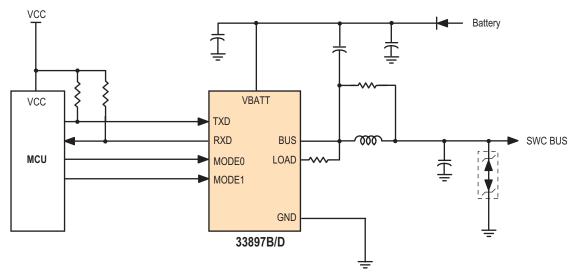


Figure 2. 33897B/D Simplified Application Diagram

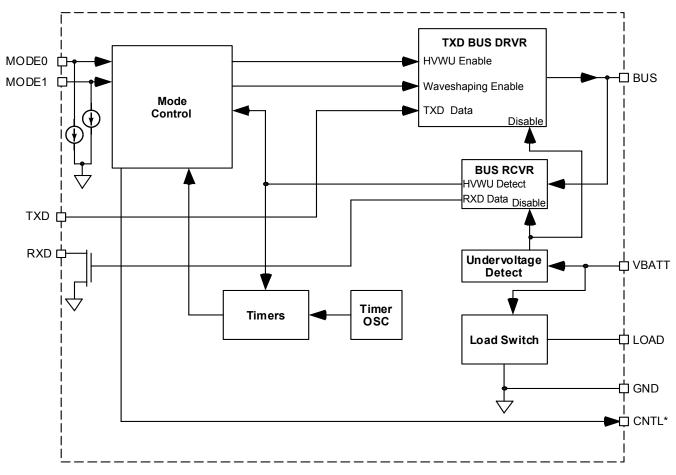
# **DEVICE VARIATIONS**

**Table 1. Device Variations** 

Part No.	Load Voltage Sleep Mode	Other Significant Differences	See Page
33897		14-Pin Package	<u>8</u>
		14-Pin Package	<u>6, 7, 8</u>
33897T	1.0 V Max	• Quiescent Current in Sleep Mode, 5.0V $\leq$ V <sub>BATT</sub> $\leq$ 13V, Typical - 55 $\mu$ A, Max - 75 $\mu$ A	
		ESD Voltage: Machine Model ±100V	
		14-Pin Package	<u>8</u>
33897A		Removes diode drop during Sleep Mode	
		May not detect Loss of Ground under certain module characteristics.	
		8-Pin Package	<u>2, 4, 6, 7, 8 ,13, 16</u>
33897B		Removes diode drop during Sleep Mode	
33097B		Does not include the CNTL terminal	
		May not detect Loss of Ground under certain module characteristics.	
	0 1 V Max	14-Pin Package	8
*33897C	U. I V IVIAX	Removes diode drop during Sleep Mode	_
33097C		Effectively detects Loss of Ground	
		ESD Voltage: Human Body Model ±1500V, Machine Model ±100V	
		8-Pin Package	2, 4, 6, 7, 8 ,13, 16
		Removes diode drop during Sleep Mode	
*33897D		Effectively detects Loss of Ground	
		Does not include the CNTL terminal	
		ESD Voltage: Human Body Model ±1500V, Machine Model ±100V	

<sup>\*</sup>Recommended device for all new designs

# INTERNAL BLOCK DIAGRAM



\*CNTL terminal is present on 33897/A/C/T only.

Figure 3. 33897/A/B/C/D/T Simplified Internal Block Diagram

# **PIN CONNECTIONS**

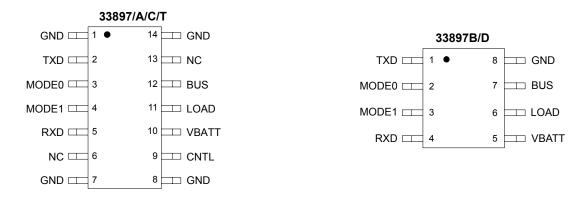


Figure 4. 33897/A/B/C/D/T Pin Connections

Table 2. Pin Definitions

A functional description of each terminal can be found in the Functional Pin Description section, beginning on page 13.

33897/A/C/T Terminal	33897B/D Terminal	Pin Name	Formal Name	Definition
1, 7, 8, 14	8	GND	Ground	Electrical Common Ground and Heat removal. A good thermal path will also reduce the die temperature.
2	1	TXD	Transmit Data	Data input here will appear on the BUS terminal. A logic [0] will assert the bus, a logic [1] will make the bus go to the recessive state.
3, 4	2, 3	MODE0, MODE1	Mode Control	These Pins control Sleep Mode, Transmit Level, and Speed. They have weak pulldowns.
5	4	RXD	Receive Data	Open drain output of the data on BUS. A recessive bus = a logic [1], a dominant bus = logic [0]. An external pullup is required.
6, 13	-	NC	No Connect	No internal connection to these Pins. Pin 13 can be connected to GND to allow the use of the 14-terminal or 8-terminal device. (1)
9	_	CNTL	Control	Provides a battery-level logic signal.
10	5	VBATT	Battery	Power input. An external diode is needed for reverse battery protection.
11	6	LOAD	Load	The external bus load resistor connects here to prevent bus pullup in the event of loss of module ground.
12	7	BUS	Bus	This terminal connects to the bus through external components.

# Notes

1. Module boards can be planned for the 14-terminal package and still use the 8-terminal package.

# **ELECTRICAL CHARACTERISTICS**

## **MAXIMUM RATINGS**

## Table 3. Maximum Ratings

All voltages are with respect to ground unless otherwise noted.

Rating	Symbol	Value	Unit
Electrical Ratings			
Supply Voltage	V <sub>BATT</sub>	-0.3 to 40	V
Input Logic Voltage	V <sub>IN</sub>	-0.3 to 7.0	V
RXD Pin Voltage	V <sub>RXD</sub>	-0.3 to 7.0	V
CNTL Pin Voltage (33897/A/C/T only)	V <sub>CNTL</sub>	-0.3 to 40	V
ESD Voltage <sup>(2)</sup> Human Body Model All Pins Except BUS 33897/A/B/T	V <sub>ESD</sub>	±2000	V
33897C/D BUS Terminal (All Pkgs) Machine Model 33897/A/B 33897C/D/T		±1500 ±4000 ±200 ±100	
Thermal Ratings			·!
Ambient Operating Temperature <sup>(3)</sup>	T <sub>A</sub>	-40 to 125	°C
Junction Operating Temperature	TJ	-40 to 150	°C
Storage Temperature	T <sub>STG</sub>	-55 to 150	°C
Junction-to-Ambient Thermal Resistance	$R_{ hetaJA}$	150	°C/W
Peak Package Reflow Temperature During Reflow (4), (5)	T <sub>PPRT</sub>	Note 5.	°C

### Notes

- 2. ESD testing is performed in accordance with the Human Body Model ( $C_{ZAP}$  = 100 pF,  $R_{ZAP}$  = 1500  $\Omega$ ), Machine Model ( $C_{ZAP}$  = 200 pF,  $R_{ZAP}$  = 0  $\Omega$ ).
- 3. When using the 8-terminal device, consider the power dissipation at a high operating voltage and maximum network loading at ambient temperatures exceeding 85°C.
- 4. Pin soldering temperature limit is for 10 seconds maximum duration. Not designed for immersion soldering. Exceeding these limits may cause malfunction or permanent damage to the device.
- Freescale's Package Reflow capability meets Pb-free requirements for JEDEC standard J-STD-020C. For Peak Package Reflow Temperature and Moisture Sensitivity Levels (MSL),
   Go to www.freescale.com, search by part number [e.g. remove prefixes/suffixes and enter the core ID to view all orderable parts. (i.e. MC33xxxD enter 33xxx), and review parametrics.

# STATIC ELECTRICAL CHARACTERISTICS

**Table 4. Static Electrical Characteristics** 

Characteristics noted under conditions of -40  $^{\circ}$ C  $\leq$  T<sub>A</sub>  $\leq$  125  $^{\circ}$ C, unless otherwise stated. Voltages are relative to GND unless otherwise noted. All positive currents are into the terminal. All negative currents are out of the terminal.

Characteristic	Symbol	Min	Тур	Max	Unit
GENERAL	I I		<u> </u>		I
Quiescent Current					
Sleep	I <sub>QSLP</sub>				
$5.0 \text{ V} \le \text{V}_{\text{BATT}} \le 13 \text{ V}^{(6)}$ 33897/A/B/C/D		_	45	60	μА
33897T		-	55	75	
Awake with Transmitter Disabled	I <sub>QATDIS</sub>		-	4.0	mA
$5.0 \text{ V} \leq \text{V}_{\text{BATT}} \leq 26.5 \text{ V}$		_		9.0	mA
Awake with Transmitter Enabled	I <sub>QATEN</sub>		-	9.0	IIIA
$5.0 \text{ V} \le \text{V}_{\text{BATT}} \le 26.5 \text{ V}$		_			
Undervoltage Shutdown	V <sub>BATTUV</sub>	4.0	-	5.0	V
Undervoltage Hysteresis	V <sub>UVHYS</sub>	0.1	_	0.5	V
Thermal Shutdown (7)	T <sub>SD</sub>			190	°C
$5.0 \text{ V} \le \text{V}_{\text{BATT}} \le 26.5 \text{ V}$		150	_		
Thermal Shutdown Hysteresis (7)	T <sub>SDHYS</sub>			20	°C
$5.0 \text{ V} \le \text{V}_{\text{BATT}} \le 26.5 \text{ V}$		10	-		
LOGIC I/O, MODE0, MODE1, TXD, RXD					
Logic Input Low Level (MODE0, MODE1, and TXD)	V <sub>IL</sub>				V
$5.0 \text{ V} \le \text{V}_{\text{BATT}} \le 26.5 \text{ V}$		_	_	0.8	
Logic Input High Level (MODE0, MODE1, and TXD)	V <sub>IH</sub>				V
$5.0 \text{ V} \le \text{V}_{\text{BATT}} \le 26.5 \text{ V}$		2.0	_	-	
Mode Pin Pulldown Current (MODE0 and MODE1)	I <sub>PD</sub>				μА
Pin Voltage = 0.8 V, 5.0 V $\leq$ V <sub>BATT</sub> $\leq$ 26.5 V		10	_	50	
Receiver Output Low (RXD)	V <sub>OL</sub>				V
$I_{IN}$ = 2.0 mA, 5.0 V $\leq$ V <sub>BATT</sub> $\leq$ 26.5 V	02	-	_	0.45	
CNTL (33897/A/C/T ONLY)	LL				
CNTL Output Low	V <sub>OLCNTL</sub>				V
$I_{IN}$ = 5.0 $\mu$ A, 5.0 V $\leq$ V <sub>BATT</sub> $\leq$ 26.5 V		-	_	0.8	
CNTL Output High	V <sub>OHCNTL</sub>				V
$I_{OUT}$ = 180 $\mu$ A, 5.0 V $\leq$ V <sub>BATT</sub> $\leq$ 26.5 V		V <sub>BATT</sub> - 0.8	-	$V_{BATT}$	

#### Notes

- 6. After t<sub>CNTLFDLY</sub>
- 7. Thermal shutdown causes the BUS output driver to be disabled. Guaranteed by characterization.

Table 4. Static Electrical Characteristics (continued)

Characteristics noted under conditions of -40°C  $\leq$  T<sub>A</sub>  $\leq$  125°C, unless otherwise stated. Voltages are relative to GND unless otherwise noted. All positive currents are into the terminal. All negative currents are out of the terminal.

Characteristic	Symbol	Min	Тур	Max	Unit
LOAD	I			1	
LOAD Voltage Rise (8)	V <sub>LDRISE</sub>				V
Normal Speed and Voltage Mode, Transmit High- Voltage Mode, Transmit High-Speed Mode					
$I_{IN}$ = 1.0 mA, 5.0 V $\leq$ V <sub>BATT</sub> $\leq$ 26.5 V		-	_	0.1	
Sleep Mode					
I <sub>IN</sub> = 7.0 mA 33897/T		_	_	1.0	
I <sub>IN</sub> = 7.0 mA <sup>(9)</sup> 33897A/B/C/D		_	_	0.1	
Loss of Battery		_	_	1.0	
I <sub>IN</sub> = 7.0 mA					
LOAD Leakage During Loss of Module Ground (10)	I <sub>LDLEAK</sub>				μА
$0.0 \text{ V} \le \text{V}_{\text{BATT}} \le 18 \text{ V}$ 33897/A/B/T	EBLLAR	0.0	_	-90	,
0.0 V ≤ V <sub>BATT</sub> ≤ 18 V 33897C/D		-10	_	10	
BUS					
Passive Out BUS Leakage					μА
Passive In	I <sub>LEAK</sub>				,
$0.0 \text{ V} \le \text{V}_{\text{BATT}} \le 26.5 \text{ V}, -1.5 \text{ V} \le \text{V}_{\text{BUS}} < 0 \text{ V}$	LL/IIX	-5.0	_	5.0	
Active In	I <sub>LKAI</sub>				
$0.0 \text{ V} \le \text{V}_{\text{BATT}} \le 26.5 \text{ V}, 0 \text{ V} < \text{V}_{\text{BUS}} \le 12.5 \text{ V}$		-5.0	_	5.0	
BUS Leakage During Loss of Module Ground (11)					
$0.0 \text{ V} \le \text{V}_{\text{BATT}} \le 18 \text{ V}$ 33897/A/B/T	I <sub>BLKLOG</sub>	-10	_	10	
$0.0 \text{ V} \le \text{V}_{\text{BATT}} \le 18 \text{ V}$ 33897C/D		0.0	_	-90	
High-Voltage Wake-up Mode Output High Voltage				30	V
12 V $\leq$ V <sub>BATT</sub> $\leq$ 26.5 V, 200 $\Omega$ $\leq$ R <sub>L</sub> $\leq$ 3332 $\Omega$					V
33897/T	V <sub>HVWUOHF</sub>	9.7	_	12.5	
33897A/B/C/D	VHVWUOHO	9.9	_	12.5	
$5.0 \text{ V} \le \text{V}_{\text{BATT}} < 12 \text{ V}, 200 \Omega \le \text{R}_{\text{L}} \le 3332 \Omega$	- HVWUOHO	Lesser of V <sub>BAT</sub> - 1.5 or 9.7		V <sub>BATT</sub>	
High-Speed Mode Output High Voltage	V <sub>OHHS</sub>	5/11		DATI	V
8.0 V $\leq$ V <sub>BATT</sub> $\leq$ 16 V, 75 $\Omega$ $\leq$ R <sub>L</sub> $\leq$ 135 $\Omega$	▼ OHHS	4.2	_	5.1	
Normal Mode Output High Voltage					V
6.0 V $\leq$ V <sub>BATT</sub> $\leq$ 26.5 V, 200 Ω $\leq$ R <sub>L</sub> $\leq$ 3332 Ω	V <sub>NOHF</sub>	4.4	_	5.1	
$5.0 \text{ V} \le \text{V}_{\text{BATT}} < 6.0 \text{ V}, 200 \Omega \le \text{R}_{\text{L}} \le 3332 \Omega$	V <sub>NOHO</sub>	Lesser of V <sub>BATT</sub> - 1.6 or 4.4	-	Lesser of V <sub>BATT</sub> or 5.1	
BUS Low Voltage	V <sub>OL</sub>				V
$5.0 \text{ V} \le \text{V}_{\text{BATT}} \le 26.5 \text{ V}, 200 \Omega \le \text{R}_{\text{L}} \le 3332 \Omega$		-0.2	_	0.2	
Short Circuit BUS Output Current	I <sub>BSC</sub>				mA
Dominant State, 5.0 V ≤ V <sub>BATT</sub> ≤ 26.5 V	130	-350	_	-150	
5,					

# Notes

- 8. GMW3089V2.4 specifies the maximum load voltage rise to be 0.1 V whenever module battery is intact, including when in Sleep mode. The maximum load voltage rise of 1.0 V in Sleep mode is a GM-approved exception to GMW3089V2.4.
- 9. 33897A/B/C/D remove diode drop during Sleep mode.
- 10. LOAD terminal is at system ground voltage.
- 11. BUS terminal is at system ground voltage

# Table 4. Static Electrical Characteristics (continued)

Characteristics noted under conditions of -40°C  $\leq$  T<sub>A</sub>  $\leq$  125°C, unless otherwise stated. Voltages are relative to GND unless otherwise noted. All positive currents are into the terminal. All negative currents are out of the terminal.

Characteristic	Symbol	Min	Тур	Max	Unit
BUS (CONTINUED)	<u> </u>	1			
Input Threshold					V
Awake 5.0 V ≤ V <sub>BATT</sub> ≤ 26.5 V	$V_{BIA}$	2.0	-	2.2	
Sleep $12 \text{ V} \le \text{V}_{\text{BATT}} \le 26.5 \text{ V}$	$V_{BISF}$	6.6	-	7.9	
Sleep 5.0 V ≤ V <sub>BATT</sub> < 12 V	V <sub>BISO</sub>	Lesser of 6.6 V or V <sub>BATT</sub> - 4.3	-	Lesser of 7.9 V or V <sub>BATT</sub> - 3.25	

# **DYNAMIC ELECTRICAL CHARACTERISTICS**

# **Table 5. Dynamic Electrical Characteristics**

Characteristics noted under conditions of -40°C  $\leq$  T<sub>A</sub>  $\leq$  125°C, unless otherwise stated. Voltages are relative to GND unless otherwise noted. All positive currents are into the terminal. All negative currents are out of the terminal.

Characteristic	Symbol	Min	Тур	Max	Unit
BUS	<u>'</u>		•	•	•
Normal Speed Rising Output Delay $200~\Omega \le R_L \le 3332~\Omega,~1.0~\mu s \le Load~Time~Constants \le 4.0~\mu s$ Measured from TXD = V <sub>IL</sub> to V <sub>BUS</sub> as follows: $Max~Time~to~V_{BUSMOD} = 3.7~V,~6.0~V \le V_{BATT} \le 26.5~V~^{(12)}$ Min Time to V <sub>BUSMOD</sub> = 1.0 V, 6.0 V $\le$ V <sub>BATT</sub> $\le$ 26.5 V $^{(12)}$	t <sub>DLYNORMRO</sub>	2.0	-	6.3	μs
Max Time to $V_{BUSMOD}$ = 2.7 V, $V_{BATT}$ = 5.0 V <sup>(12)</sup> Min Time to $V_{BUSMOD}$ = 1.0 V, $V_{BATT}$ = 5.0 V <sup>(12)</sup>					
Normal Speed Falling Output Delay $200~\Omega \leq R_L \leq 3332~\Omega,~1.0~\mu s \leq Load~Time~Constants \leq 4.0~\mu s$ Measured from TXD = V <sub>IH</sub> to V <sub>BUS</sub> as follows: $Max~Time~to~V_{BUSMOD} = 1.0~V,~6.0~V \leq V_{BATT} \leq 26.5~V~^{(12)}$ Min Time to V <sub>BUSMOD</sub> = 3.7 V, 6.0 V $\leq$ V <sub>BATT</sub> $\leq$ 26.5 V $^{(12)}$ Max Time to V <sub>BUSMOD</sub> = 1.0 V, V <sub>BATT</sub> = 5.0 V $^{(12)}$ Min Time to V <sub>BUSMOD</sub> = 2.7 V, V <sub>BATT</sub> = 5.0 V $^{(12)}$	t <sub>DLYNORMFO</sub>	1.8	-	8.5	μs
High-Speed Rising Output Delay $75~\Omega \le R_L \le 135~\Omega,~0.0~\mu s \le Load~Time~Constants \le 1.5~\mu s, \\ 8.0~V \le V_{BATT} \le 16~V$ Measured from TXD = $V_{IL}$ to $V_{BUS}$ as follows: Max Time to $V_{BUS}$ = 3.7 $V^{(13)}$ Min Time to $V_{BUS}$ = 1.0 $V^{(13)}$	t <sub>DLYHSRO</sub>	0.1	-	1.7	μѕ
High-Speed Falling Output Delay $75~\Omega \le R_L \le 135~\Omega,~0.0~\mu s \le Load~Time~Constants \le 1.5~\mu s, \\ 8.0~V \le V_{BATT} \le 16~V$ Measured from TXD = $V_{IH}$ to $V_{BUS}$ as follows: Max Time to $V_{BUS}$ = 1.0 $V_{IS}$ (13) Min Time to $V_{BUS}$ = 3.7 $V_{IS}$ (13)	t <sub>DLYHSFO</sub>	0.04	-	3.0	μs

## Notes

- 12.  $V_{BUSMOD}$  is the voltage at the BUSMOD node in <u>Figure 7</u>, page <u>15</u>.
- 13.  $V_{BUS}$  is the voltage at the BUS terminal in <u>Figure 8</u>, page <u>15</u>.

# Table 5. Dynamic Electrical Characteristics (continued)

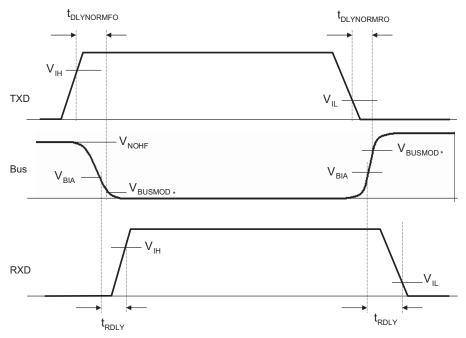
Characteristics noted under conditions of -40  $^{\circ}$ C  $\leq$  T<sub>A</sub>  $\leq$  125  $^{\circ}$ C, unless otherwise stated. Voltages are relative to GND unless otherwise noted. All positive currents are into the terminal. All negative currents are out of the terminal.

Characteristic	Symbol	Min	Тур	Max	Unit
BUS (CONTINUED)		l	I	1	
High-Voltage Rising Output Delay $200~\Omega \leq R_L \leq 3332~\Omega,~1.0~\mu s \leq Load~Time~Constants \leq 4.0~\mu s$ Measured from TXD=V $_{IL}$ to V $_{BUS}$ as follows: Max Time to V $_{BUSMOD}$ = 3.7 V, 6.0 V $\leq$ V $_{BATT}$ $\leq$ 26.5 V $^{(14)}$ Min Time to V $_{BUSMOD}$ = 1.0 V, 6.0 V $\leq$ V $_{BATT}$ $\leq$ 26.5 V $^{(14)}$ Max Time to V $_{BUSMOD}$ = 9.4 V, 12.0 V $\leq$ V $_{BATT}$ $\leq$ 26.5 V $^{(14)}$	t <sub>DLYHVRO</sub>	2.0 2.0 2.0	- - -	6.3 6.3 18	μѕ
High-Voltage Falling Output Delay $200~\Omega \leq R_L \leq 3332~\Omega,~1.0~\mu s \leq Load~Time~Constants \leq 4.0~\mu s, \\ 12.0~V \leq V_{BATT} \leq 26.5~V \\ Measured~from~TXD=V_{IH}~to~V_{BUS}~as~follows: \\ Max~Time~to~V_{BUSMOD} = 1.0~V~^{(14)} \\ Min~Time~to~V_{BUSMOD} = 3.7~V~^{(14)}$	t <sub>DLYHVFO</sub>	1.8 1.8	- -	14 14	μs
RECEIVER RXD		l	·	•	
Receive Delay Time (5.0 V $\leq$ V <sub>BATT</sub> $\leq$ 26.5 V) Awake	t <sub>RDLY</sub>	0.2	_	1.0	μs
Receive Delay Time (BUS Rising to RXD Falling, $5.0~\text{V} \le \text{V}_{\text{BATT}} \le 26.5~\text{V})$ Sleep	t <sub>RDLYSL</sub>	10	_	70	μs
CNTL					
CNTL Falling Delay Time (5.0 V $\leq$ V <sub>BATT</sub> $\leq$ 26.5 V) (33897/A/C/T only)	t <sub>CNTLFDLY</sub>	300	_	1000	ms

## Notes

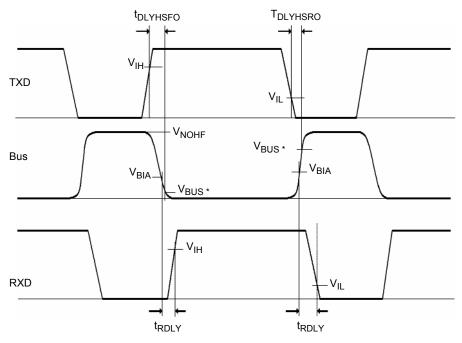
<sup>14.</sup>  $V_{BUSMOD}$  is the voltage at the BUSMOD node in Figure 7, page 15.

# **TIMING DIAGRAMS**



 $<sup>^{\</sup>star}$   $V_{\mbox{\footnotesize BUSMOD}}$  is the voltage at the BUSMOD node in Figure 7.

Figure 5. TXD, Bus and RXD Waveforms in Normal Mode



 $<sup>^{\</sup>star}$  V<sub>BUS</sub> is the voltage at the BUS terminal in Figure 8.

Figure 6. TXD, Bus and RXD Waveforms in High Speed Mode

# **FUNCTIONAL DESCRIPTION**

# INTRODUCTION

The 33897 Series is intended for use as a physical layer device in a Single Wire CAN communications bus. Communications takes place from a single terminal over a single wire using a common ground for a current return path. Two data rates are available, with the high rate used for factory or assembly line communications and the lower for

actual system communications where the radiated EMI of the higher rate could be an issue.

Two Pins control the mode of operation (sleep, low-speed, high-speed, and high-voltage wake-up).

#### **FUNCTIONAL PIN DESCRIPTION**

The 33897 Series is intended to be used with an MCU to control its operation and to process and generate the data for the bus.

## GROUND PINS (33897/A/C/T)

The four ground PINS are not only for electrical conduction, their number and locations at each of the four corners serve also to remove heat from the IC. The biggest benefit of this is obtained by putting a lot of copper on the PCB in this area and, if ground is an internal layer, by adding numerous plated-through connections to it with the largest diameter holes the layout can use.

#### **TXD DATA**

The data driven onto the SWCAN bus is inverted from the TXD terminal. A "1" driven on TXD will result in an undriven (recessive) state (bus at near zero volts). When the TXD terminal is low, the output goes to a driven state. The voltage and waveshaping in the driven state is determined by the levels on the MODE0 and MODE1 Pins (refer to Table 6).

Table 6. Mode Control Logic Levels

Logic	Level	Operation
MODE0	MODE1	Operation
0	0	Sleep Mode
0	1	High Voltage Wake-Up Mode
1	0	High Speed Mode
1	1	Normal Mode

#### MODE CONTROL

The MODE Pins control the transmitter filtering and BUS voltage and the IC sleep mode operation. <u>Table 6</u> shows the mode versus the logic levels on MODE0 and MODE1.

The MODE0 and MODE1 Pins have a weak pulldown in the IC so that in case the Pins are not driven, the device will enter the sleep mode. This is usually the situation as the MCU comes out of reset, before the driving signals have been configured as outputs.

## **RXD Data**

The data received on the bus is translated to logic levels on this terminal. This terminal is a logic high when the bus is in the recessive state (near zero volts) and is logic low when the bus is in either the normal or high-voltage dominant state.

This is an open-drain type of output that requires an external resistor to pull it up. When the device is in sleep mode, the output will be off unless a high-voltage wake-up level is detected on the bus. If the wake-up level is detected, the output will be driven by the data on the bus. If the level of the data returns to normal level, the output will return to off after a short delay unless a non-sleep mode condition is set by the MCU.

#### **LOAD Switch**

This switch is on in all operating modes unless a loss of ground is detected. If this happens, the switch is opened and the resistor normally attached to its terminal will no longer pass current to or from the bus.

# CNTL Output (33897/A/C/T ONLY)

This logic level signal is used to control a  $V_{CC}$  regulator. When the output is low, the  $V_{CC}$  regulator is expected to shutdown. This is normally used to shut down the MCU and all the devices powered by  $V_{CC}$  when the IC is in sleep mode. This is done to save power. When the part is taken out of the sleep mode by the higher-than-normal bus voltage, this terminal is asserted high and the  $V_{CC}$  regulator brings its output up to the regulated level. This starts the MCU, which controls the mode of the IC. The MCU must change the mode signals to non-sleep mode levels in order to keep this terminal from going low. There is a delay to allow the MCU to fully wake up and take control after the high-voltage signaling is removed before the level on this output returns low. After a delay time, even if the bus is at high voltage, the IC will return to sleep mode if both MODE Pins are low.

# **VBATT Input**

This power input is not reverse battery protected and should use an external diode to protect it from damage owing to reverse battery if this protection is desired. The voltage drop of the diode must be taken into consideration when the operating range of the system is being determined. This

# FUNCTIONAL DESCRIPTION FUNCTIONAL BLOCK DIAGRAM COMPONENTS

diode is generally used to protect the entire module from reverse battery and should be selected accordingly.

#### **BUS I/O**

This input/output may require electrostatic discharge (ESD) and/or EMI external circuitry. A set of components is

shown in the simplified application diagrams on <u>page 16</u> of this datasheet. The value of the capacitor should be adjusted downward in direct proportion to the added capacitance of the ESD or EMI circuits. The series resistance of the inductor should be kept below 3.5  $\Omega$  to prevent its voltage drop from significantly degrading system noise margins.

#### FUNCTIONAL BLOCK DIAGRAM COMPONENTS

#### **Timer OSC**

This circuit generates a 500 kHz signal to be used for internal logic. It is the reference for some of the required delays.

#### **Timers**

This circuit contains the timing logic used to hold the CNTL active for the required time after the conditions for sleep mode have been met. It is also used to keep the TXD driver active for a period of time after it has generated a passive level on the bus.

#### **Mode Control**

This circuit contains the control logic for the various operating modes and conditions required for the IC.

#### **BUS RCVR**

This circuit translates the levels on the BUS terminal to a CMOS level indicating the presence of a logic [0] or a logic [1]. It also determines the presence of a high-voltage wake-up (HVWU) signal that is passed to Mode Control and Timers circuits. An analog filter is used to "de-glitch" the high-voltage wake-up signal and prevent false exits from the sleep mode.

## **TXD BUS DRVR**

This circuit drives the BUS. It can drive it with the higher voltage wake-up signals when enabled by the Mode Control circuit. It can also provide waveshaping for reduced EMI or not provide it for the higher data rate mode. The actual data is received on TXD at CMOS logic levels, then translated by this circuit to the necessary operating voltages.

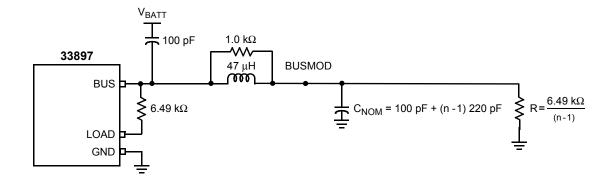
#### **Undervoltage Detect**

This circuit monitors internal operating voltage to assure proper operation of the part. If a low-voltage condition is detected, it sends a signal to disable the BUS RCVR and TXD BUS DRVR circuits. This prevents incorrect data from being put on the bus or sent to the MCU.

#### **Load Switch**

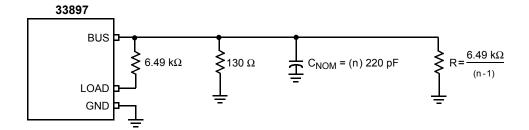
The LOAD switch provides a path for an external resistor connected to the BUS to be connected to ground. When a loss of ground is detected, this switch is opened to prevent the current that would normally be flowing to the ground from the module from going back through the load resistor and raising the bus level. The circuit is opened when the voltage between GND and VBATT becomes too low as would be the case if module ground were lost.

# **BUS LOADING PARAMETERS**



Note: The letter "n" represents the number of nodes in the system.

Figure 7. Transmitter Delays in Normal and Transmit High-Voltage Wake-Up Modes



Note: The letter "n" represents the number of nodes in the system.

Figure 8. Transmitter Delays in Transmit High-Speed Mode

# TYPICAL APPLICATIONS

The 33897/A/C/T can be used in applications where the module includes a regulator that has the capability of going into Sleep mode by having an Enable terminal. See <u>Figure 9</u>. When the module's regulator is in sleep mode, the module is turned off. The module waits for a defined wake-up voltage

level on the bus. This wake-up voltage will activate the control line, which enables the regulator and turns the module back on. This 33897/A/C/T feature allows the module to be more energy efficient since the current consumption is significantly lowered when it goes into sleep mode.

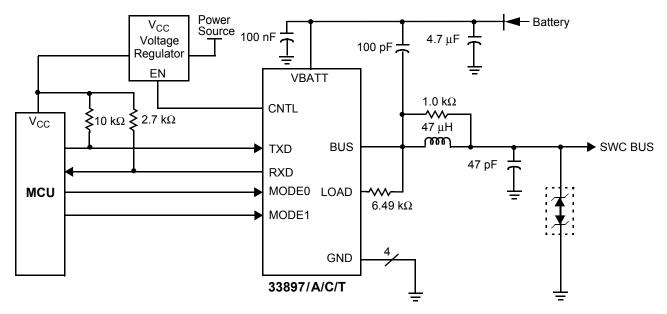


Figure 9. 33897/A/C/T Typical Application Schematic

The 33897B/D do not have a control terminal to enable the module's regulator. See <u>Figure 10</u>. The 33897B/D can be used in applications where board space is limited and there

is no need for the module to have control over its regulator via the transceiver.

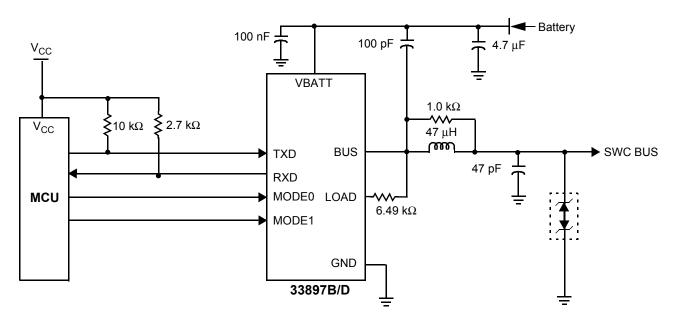
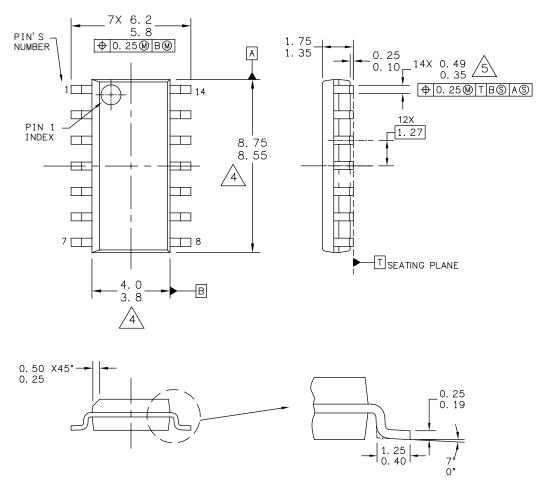


Figure 10. 33897B/D Typical Application Schematic

# **PACKAGING**

# **PACKAGE DIMENSIONS**

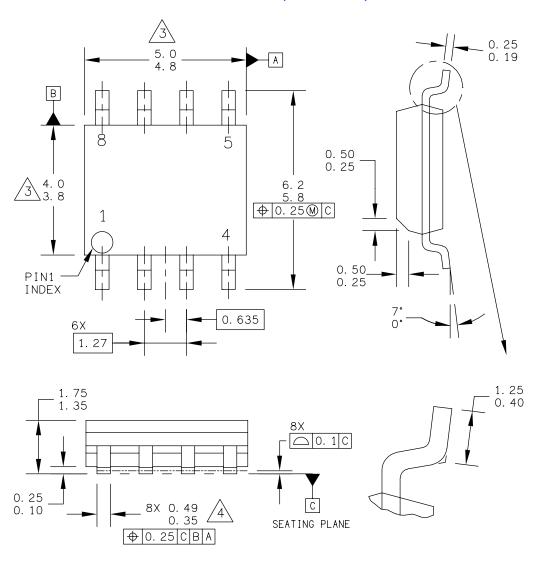
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# **REVISION HISTORY**

REVISION	DATE	DESCRIPTION OF CHANGES
9.0	5/2005	<ul> <li>Converted to Freescale format</li> <li>Added A &amp; B Versions</li> <li>Updated Device Variation Table, and Note "* Recommended device for all new designs"</li> <li>Added EF (Pb-Free) Devices, and higher soldering temperature</li> </ul>
10.0	8/2005	<ul> <li>Implemented Revision History page</li> <li>Updated Simplified Application Diagrams</li> <li>Updated Typical Application Schematic</li> </ul>
11.0	12/2005	Added 33897C and D versions and Timing Diagrams
12.0	1/2006	<ul> <li>Updated Table 4, Static Electrical Characteristics - LOAD and BUS parameters</li> <li>Updated Ordering Information.</li> </ul>
13.0	6/2006	<ul> <li>Removed "Unless otherwise noted" from Static Electrical Characteristics &amp; Dynamic Electrical Characteristics table introductions</li> </ul>
14.0	8/2006	<ul> <li>Added Part Numbers MC33897TD and MC33897TEF to Ordering Information on Page 1.</li> <li>Added 33897T to Table 1, Device Variations on Page 3, Referencing Electrical Changes per Errata MC33897TER, Revision 3 and specifying ESD variations</li> </ul>
15.0	10/2006	<ul> <li>Removed Part Numbers Mc33897TD/R2, Mc33897TEF/R2, Mc33897CLEF/R2, Pc33897CLEF/R2, Mc33897DLEF/R2, and Pc33897DLEF/R2</li> <li>Added Part Numbers Mc233897EF/R2, Mc233897TEF/R2, Mc233897AEF/R2, Mc233897EF/R2, Mc233897BEF/R2, and Mc233897DEF/R2 to the Ordering Information block on Page 1.</li> <li>Updated Device Variations on page 3 for "T" suffix products</li> <li>Split out Human Body Model on page 6 to differentiate between T and non-T versions</li> <li>Added Undervoltage Hysteresis on page 7</li> <li>Removed Peak Package Reflow Temperature During Reflow (solder reflow) parameter from Maximum Ratings on page 6. Added note with instructions to obtain this information from www.freescale.com.</li> </ul>
16.0	6/2007	Removed watermark, "Advance Information" from page 1.

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